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- ☐ Advanced

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 fingerprint <paragraph>
 (orientation <near/3> model)

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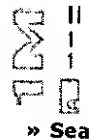
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- ☐ Home
- ☐ What Can I Access?
- ☐ Log-out

Tables of Contents

- ☐ Journals & Magazines
- ☐ Conference Proceedings
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- ☐ By Author
- ☐ Basic
- ☐ Advanced

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1 **Synthetic fingerprint-image generation**
Cappelli, R.; Erol, A.; Maio, D.; Maltoni, D.;

Pattern Recognition, 2000. Proceedings. 15th International Conference on , Volume: 3 , 3-7 Sept. 2000

Pages:471 - 474 vol.3

[\[Abstract\]](#)
[\[PDF Full-Text \(440 KB\)\]](#)
IEEE CNF
2 **Automatic fingerprint classification system using fuzzy neural techniques**
Mohamed, S.M.; Nyongesa, H.;

Fuzzy Systems, 2002. FUZZ-IEEE'02. Proceedings of the 2002 IEEE International Conference on , Volume: 1 , 12-17 May 2002

Pages:358 - 362

[\[Abstract\]](#)
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```
((position* or locat* or
coordinate) <near/7> (core
and delta)) <paragraph>
((ridge or valley or peak or
```

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